Exams for group M18-416

Thu, 20 Dec	14:30 — 16:05	TEST English Language (Technological Terminology) Ivanova E.G. A-308
Mon, 24 Dec	12:45 — 14:20	ATT Nuclear Physics Garmash A.A. B-214
Mon, 24 Dec	14:30 — 16:05	TEST Interaction of RF Electromagnetic Radiation with Semiconductor Electronics Materials (Physics Principals) Shurenkov V.V. D-408
Mon, 24 Dec	16:15 — 17:50	ATT Optoelectronic Devices and Systems Voronov Y.A. D-311
Thu, 27 Dec	12:45 — 14:20	TEST Selected Chapters of Higher Mathematics Trushkin N.S. V-315
Thu, 27 Dec	14:30 — 16:05	ATT Microelectronic Sensors and Transducers Podlepetskiy B.I. D-405
Thu, 27 Dec	16:15 — 17:50	ATT Electromagnetic Compatibility (Emc) Shurenkov V.V. B-212
Thu, 27 Dec	17:55 — 19:30	TEST Academic (Research) Practice Samotaev N.N. dep.27
Thu, 10 Jan	09:00 — 13:00	EXAM Nuclear Physics Garmash A.A. V-417
Mon, 14 Jan	09:00 — 13:00	EXAM Optoelectronic Devices and Systems Voronov Y.A. D-311
Fri, 18 Jan	09:00 — 13:00	EXAM Electromagnetic Compatibility (Emc) Shurenkov V.V. D-311
Wed, 23 Jan	09:00 — 13:00	EXAM Microelectronic Sensors and Transducers Podlepetskiy B.I. D-303